

# BT1308W series D

Triacs logic level
Rev. 01 — 27 February 2008

**Product data sheet** 

# **Product profile**

### 1.1 General description

Passivated sensitive gate triacs in a SOT223 surface-mountable plastic package

#### 1.2 Features

- Sensitive gate
- Direct interfacing to logic level ICs
- Gate triggering in four quadrants
- Direct interfacing to low-power gate drive circuits

### 1.3 Applications

- General purpose switching and phase control
- Low-power AC fan speed controllers

#### 1.4 Quick reference data

- $V_{DRM} \le 400 \text{ V (BT1308W-400D)}$
- $V_{DRM} \le 600 \text{ V (BT1308W-600D)}$
- $I_{TSM} \le 9 \text{ A (t = 20 ms)}$

- $I_{GT} \le 5 \text{ mA}$
- $I_{GT} \le 7 \text{ mA } (T2-G+)$
- $I_{T(RMS)} \le 0.8 A$

# **Pinning information**

Table 1. **Pinning** 

	•			
Pin	Description	Simplified outline	Graphic symbol	
1	main terminal 1 (T1)		N 1	
2	main terminal 2 (T2)	4	T2—T1	
3	gate (G)		sym051	
4	mounting base; main terminal 2 (T2)			
		SOT223		



# 3. Ordering information

### Table 2. Ordering information

Type number	Package	Package			
	Name	Description	Version		
BT1308W-400D	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223		
BT1308W-600D					

# 4. Limiting values

#### Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage	BT1308W-400D	-	400	V
		BT1308W-600D	-	600	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{sp} \le 107.4 ^{\circ}\text{C}$ ; see Figure 4 and 5	-	8.0	Α
I <sub>TSM</sub>	non-repetitive peak on-state current	full sine wave; $T_j = 25$ °C prior to surge; see Figure 2 and 3			
		t = 20 ms	-	9	Α
		t = 16.7 ms	-	10	Α
l <sup>2</sup> t	I <sup>2</sup> t for fusing	$t_p = 10 \text{ ms}$	-	0.32	A <sup>2</sup> s
dl <sub>T</sub> /dt	rate of rise of on-state current	$I_{TM}$ = 1 A; $I_G$ = 20 mA; $dI_G/dt$ = 0.2 A/ $\mu$ s			
		T2+ G+	-	50	A/μs
		T2+ G-	-	50	A/μs
		T2- G-	-	50	A/μs
		T2- G+	-	10	A/μs
$I_{GM}$	peak gate current		-	1	Α
$P_{GM}$	peak gate power		-	5	W
P <sub>G(AV)</sub>	average gate power	over any 20 ms period	-	0.1	W
T <sub>stg</sub>	storage temperature		-40	+150	°C
Tj	junction temperature		-	125	°C

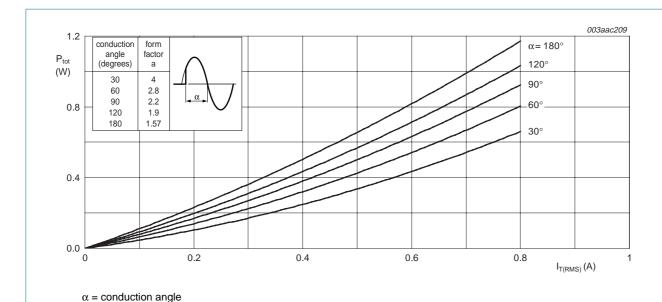


Fig 1. Total power dissipation as a function of RMS on-state current; maximum values

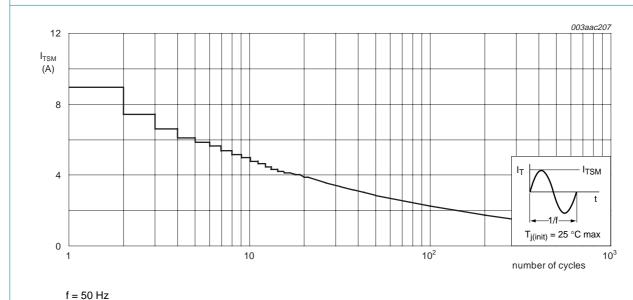
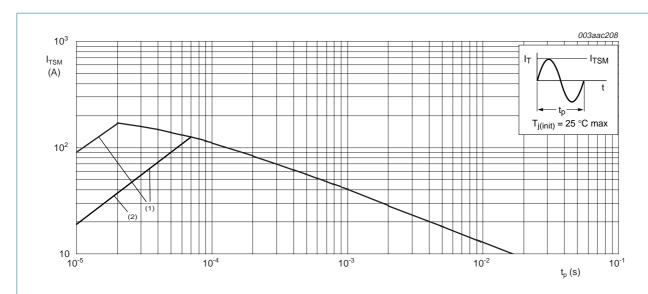


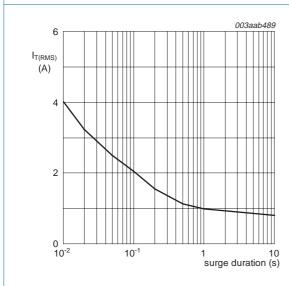
Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



 $t_p \le 20 \text{ ms}$ 

- (1) dI<sub>T</sub>/dt limit
- (2) T2- G+ quadrant limit

Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values



f = 50 Hz T<sub>sp</sub> = 107.4 °C

Fig 4. RMS on-state current as a function of surge duration; maximum values

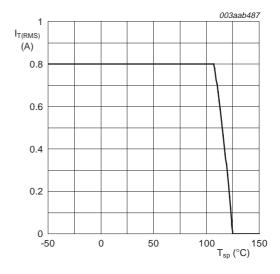
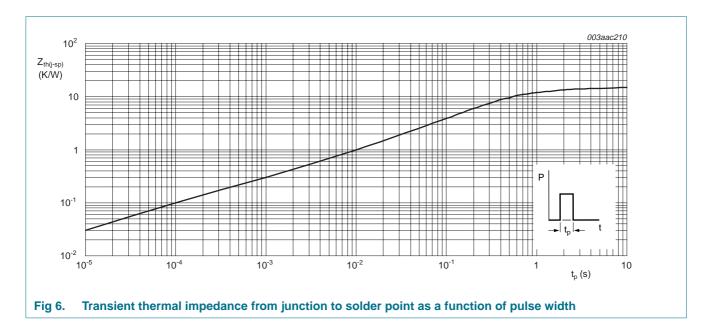


Fig 5. RMS on-state current as a function of solder point temperature; maximum values

## 5. Thermal characteristics

#### Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j\text{-sp})}$	thermal resistance from junction to solder point	full cycle; see Figure 6	-	-	15	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	full cycle				
		for minimum footprint; see Figure 13	-	156	-	K/W
		for pad area; see Figure 14	-	70	-	K/W

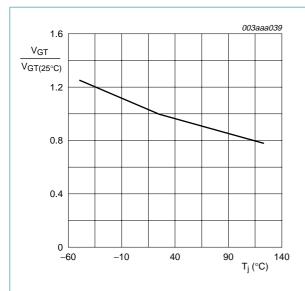


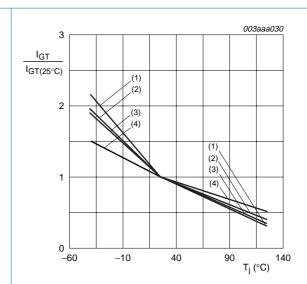
# 6. Characteristics

Table 5. Characteristics

 $T_j = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; see } \frac{\text{Figure 8}}{}$				
		T2+ G+	-	1	5	mΑ
		T2+ G-	-	2	5	mΑ
		T2- G-	-	2	5	mΑ
		T2- G+	-	4	7	mΑ
IL	latching current	$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; see } \frac{\text{Figure 10}}{\text{Figure 10}}$				
		T2+ G+	-	1	10	mΑ
		T2+ G-	-	5	10	mΑ
		T2- G-	-	1	10	mΑ
		T2- G+	-	2	10	mΑ
I <sub>H</sub>	holding current	$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; see } \frac{\text{Figure 11}}{}$	-	1	10	mΑ
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 0.85 A; see <u>Figure 9</u>	-	1.35	1.6	V
$V_{GT}$	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 7}}{}$	-	0.9	2	V
		$V_D = V_{DRM}; I_T = 0.1 A; T_j = 110 ^{\circ}C$	0.1	0.7	-	V
I <sub>D</sub>	off-state current	$V_D = V_{DRM(max)}$ ; $T_j = 125  ^{\circ}C$	-	0.1	0.5	mΑ
Dynamic	characteristics					
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM} = 0.67 \times V_{DRM(max)}; T_j = 110  ^{\circ}C;$ exponential waveform; gate open circuit	30	45	-	V/μs
dV <sub>com</sub> /dt	rate of change of commutating voltage	$V_{DM} = V_{DRM(max)}; T_j = 50  ^{\circ}C;$ $I_{TM} = 0.84  A;  dI_{com}/dt = 0.3  A/ms$	-	5	-	V/μs
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM} = 1 \text{ A}; V_D = V_{DRM(max)}; I_G = 25 \text{ mA}; dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs

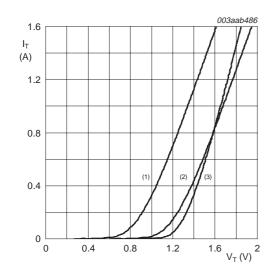




- (1) T2+ G+
- (2) T2-G+
- (3) T2-G-
- (4) T2+ G-

Fig 7. Normalized gate trigger voltage as a function of junction temperature





 $V_0 = 1.171 \ V$ 

 $R_s = 0.5125 \Omega$ 

- (1)  $T_i = 125$  °C; typical values
- (2)  $T_i = 125 \,^{\circ}C$ ; maximum values
- (3)  $T_j = 25 \,^{\circ}C$ ; maximum values

Fig 9. On-state current as a function of on-state voltage

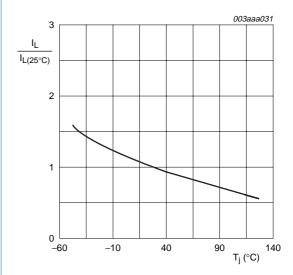
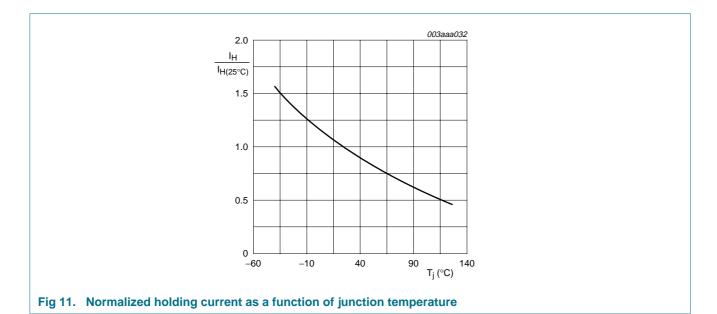


Fig 10. Normalized latching current as a function of junction temperature



# 7. Package outline

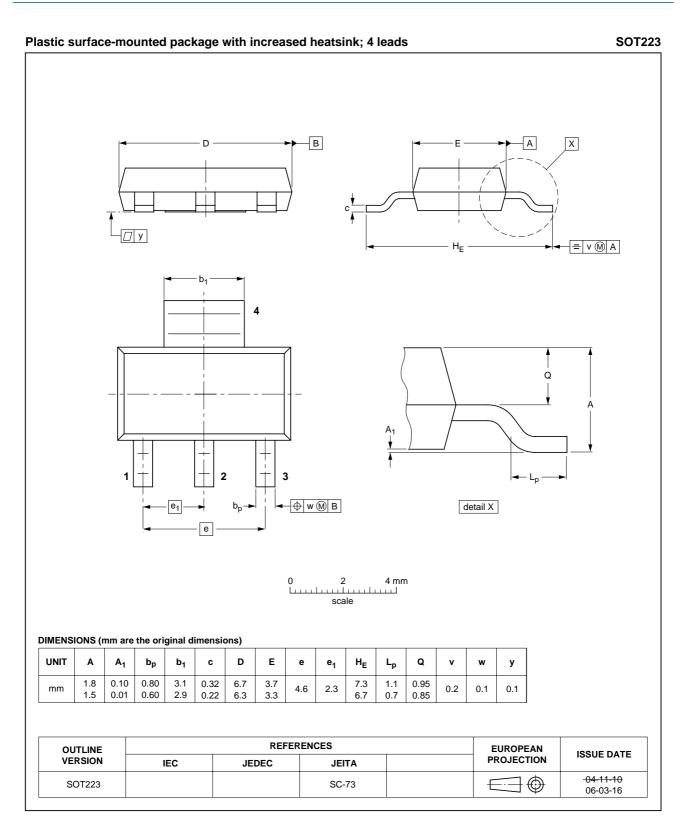
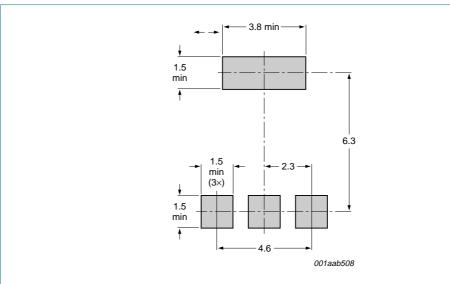


Fig 12. Package outline SOT223 (SC-73)

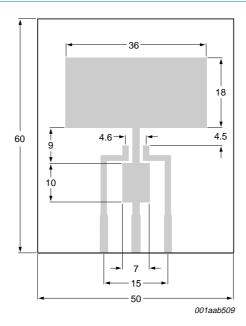
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# 8. Mounting



All dimensions are in mm.

Fig 13. Minimum footprint SOT223



All dimensions are in mm.

Printed circuit board: FR4 epoxy glass (1.6 mm thick), copper laminate (35  $\mu$ m thick).

Fig 14. Printed circuit board pad area SOT223



# 9. Revision history

### Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BT1308W_SER_D_1	20080227	Product data sheet	-	-

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Date of release: 27 February 2008

Document identifier: BT1308W\_SER\_D\_1

